Applicant(s)/Patent Under Application/Control No. Reexamination 09/691,413 LEE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2624 Wenpeng Chen **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,729,631 Α 03-1998 Wober et al. 382/232 US-В US-С US-D US-Ε F US-G US-Н US-US-1 US-J US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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